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August 1999 Revised September 2000

74ACT652

Transceiver/Register

General Description

The ACT652 consists of bus transceiver circuits with D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the input bus or from internal registers. Data on the A or B bus will be clocked into the registers as the appropriate clock pin goes to the HIGH logic level. Output Enable pins (OEAB, OEBA) are provided to control the transceiver function.

Features

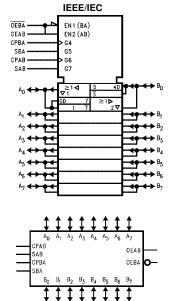
- Independent registers for A and B buses
- Multiplexed real-time and stored data
- Outputs source/sink 24 mA
- TTL-compatible inputs

Ordering Code:

| Order Number | Package Number | Package Description |
|--------------|----------------|---|
| 74ACT652SC | M24B | 24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide |
| 74ACT652MTC | MTC24 | 24-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide |
| 74ACT652SPC | N24C | 24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide |

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Logic Symbols



Connection Diagram



Pin Descriptions

| Pin Names | Description | | | | | |
|---|--------------------------------|--|--|--|--|--|
| A ₀ -A ₇ , B ₀ -B ₇ | A and B Inputs/3-STATE Outputs | | | | | |
| CPAB, CPBA | Clock Inputs | | | | | |
| SAB, SBA | Select Inputs | | | | | |
| OEAB, OEBA | Output Enable Inputs | | | | | |

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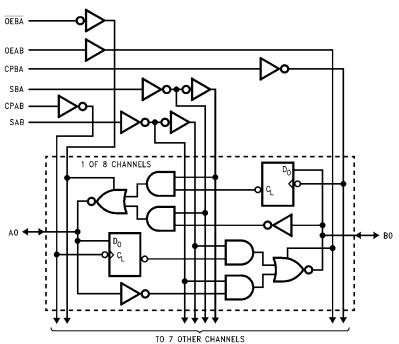
Function Table

| | | Inp | uts | | | Inputs/Outp | outs (Note 1) | Operating Mode |
|------|------|--------|--------|-----|-----|------------------------------------|------------------------------------|----------------------------|
| OEAB | OEBA | СРАВ | СРВА | SAB | SBA | A ₀ thru A ₇ | B ₀ thru B ₇ | |
| L | Н | H or L | H or L | Х | Х | Input | Input | Isolation |
| L | Н | ~ | \ | Х | Х | | | Store A and B Data |
| Х | Н | ~ | H or L | Х | Х | Input | Not Specified | Store A, Hold B |
| Н | Н | ~ | ~ | Х | Х | Input | Output | Store A in Both Registers |
| L | Х | H or L | ~ | Х | Х | Not Specified | Input | Hold A, Store B |
| L | L | ~ | ~ | Х | Х | Output | Input | Store B in Both Registers |
| L | L | Х | Х | Х | L | Output | Input | Real-Time B Data to A Bus |
| L | L | Х | H or L | Х | Н | | | Store B Data to A Bus |
| Н | Н | Х | Х | L | Х | Input | Output | Real-Time A Data to B Bus |
| Н | Н | H or L | Х | Н | Х | | | Stored A Data to B Bus |
| Н | L | H or L | H or L | Н | Н | Output | Output | Stored A Data to B Bus and |
| | | | | | | | | Stored B Data to A Bus |

H = HIGH Voltage Level

Note 1: The data output functions may be enabled or disabled by various signals at OEAB or OEBA inputs. Data input functions are always enabled, i.e., data at the bus pins will be stored on every LOW-to-HIGH transition on the clock inputs.

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

L = LOW Voltage Level

X = Immaterial

^{∠ =} LOW-to-HIGH Clock Transition

Functional Description

In the transceiver mode, data present at the HIGH impedance port may be stored in either the A or B register or both.

The select (SAB, SBA) controls can multiplex stored and real-time.

The examples in Figure 1 demonstrate the four fundamental bus-management functions that can be performed with the Octal bus transceivers and receivers.

Data on the A or B data bus, or both can be stored in the internal D-type flip-flop by LOW to HIGH transitions at the appropriate Clock Inputs (CPAB, CPBA) regardless of the Select or Output Enable Inputs. When SAB and SBA are in the real time transfer mode, it is also possible to store data without using the internal D-type flip-flops by simultaneously enabling OEAB and OEBA. In this configuration each Output reinforces its Input. Thus when all other data sources to the two sets of bus lines are in a HIGH impedance state, each set of bus lines will remain at its last state.

Note A: Real-Time Note B: Real-Time Transfer Bus B to Bus A Transfer Bus A to Bus B OEBA CPAB **CPBA** SAB SBA OEAB OEBA **CPAB CPBA** SBA L Χ Χ Χ L Н Н Χ Χ L Χ L Note C: Storage Note D: Transfer Storage Data to A or B OEAB OEBA **CPAB CPBA** SAB SBA OEAB OEBA **CPAB** SBA Χ Χ Χ Χ Н H or L Н Н H or L Н Χ Χ Χ Χ L Χ Χ Н FIGURE 1.

Absolute Maximum Ratings(Note 2)

C

Supply Voltage (V $_{\rm CC}$) $$-0.5{\rm V}\ {\rm to}\ +7.0{\rm V}$$ DC Input Diode Current (I $_{\rm IK}$)

 $\begin{array}{c} \text{V}_{\text{I}} = -0.5 \text{V} & -20 \text{ mA} \\ \text{V}_{\text{I}} = \text{V}_{\text{CC}} + 0.5 \text{V} & +20 \text{ mA} \\ \text{DC Input Voltage (V}_{\text{I}}) & -0.5 \text{V to V}_{\text{CC}} + 0.5 \text{V} \end{array}$

DC Output Diode Current (I_{OK})

$$\begin{split} V_{O} = -0.5V & -20 \text{ mA} \\ V_{O} = V_{CC} + 0.5V & +20 \text{ mA} \end{split}$$

DC Output Voltage (V $_{\rm O}$) -0.5V to V $_{\rm CC}$ + 0.5V

DC Output Source

or Sink Current (I_O) \pm 50 mA

DC V_{CC} or Ground Current

per Output Pin (I_{CC} or I_{GND}) \pm 50 mA

Storage Temperature (T $_{STG}$) $-65^{\circ}C$ to $+150^{\circ}C$

DC Latch-Up Source

or Sink Current \pm 300 mA

Junction Temperature (T_J)

IP

Recommended Operating Conditions

Minimum Input Edge Rate $\Delta V/\Delta t$

V_{IN} from 0.8V to 2.0V

V_{CC} @ 4.5V, 5.5V 125 mV/ns

Note 2: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FAC™ circuits outside databook specifications.

DC Electrical Characteristics

| Symbol | Parameter | V _{CC} T _A = +25°C | | $T_A = -40^{\circ}C \text{ to } +85^{\circ}C$ | Units | Conditions | |
|------------------|-------------------------------------|--|-----------------------|---|--------|------------|--|
| Syllibol | | (V) | Typ Guaranteed Limits | | Ullits | Conditions | |
| V _{IH} | Minimum HIGH Level | 4.5 | 1.5 | 2.0 | 2.0 | V | V _{OUT} = 0.1V |
| | Input Voltage | 5.5 | 1.5 | 2.0 | 2.0 | V | or V _{CC} – 0.1V |
| V _{IL} | Maximum LOW Level | 4.5 | 1.5 | 0.8 | 0.8 | V | V _{OUT} = 0.1V |
| | Input Voltage | 5.5 | 1.5 | 0.8 | 0.8 | V | or V _{CC} – 0.1V |
| V _{OH} | Minimum HIGH Level | 4.5 | 4.49 | 4.4 | 4.4 | V | I _{OUT} = -50 μA |
| | Output Voltage | 5.5 | 5.49 | 5.4 | 5.4 | V | 1 _{OUT} = -50 μA |
| | | | | | | | $V_{IN} = V_{IL}$ or V_{IH} |
| | | 4.5 | | 3.86 | 3.76 | V | $I_{OH} = -24 \text{ mA}$ |
| | | 5.5 | | 4.86 | 4.76 | | $I_{OH} = -24 \text{ mA (Note 3)}$ |
| V _{OL} | Maximum LOW Level | 4.5 | 0.001 | 0.1 | 0.1 | V | I 50A |
| | Output Voltage | 5.5 | 0.001 | 0.1 | 0.1 | V | $I_{OUT} = 50 \mu A$ |
| | | | | | | | $V_{IN} = V_{IL}$ or V_{IH} |
| | | 4.5 | | 0.36 | 0.44 | V | $I_{OL} = 24 \text{ mA}$ |
| | | 5.5 | | 0.36 | 0.44 | | I _{OL} = 24 mA (Note 3) |
| I _{IN} | Maximum Input | 5.5 | | ± 0.1 | ± 1.0 | μА | $V_1 = V_{CC}$, GND |
| | Leakage Current | 5.5 | | ± 0.1 | ± 1.0 | μΛ | VI = VCC, CIND |
| I _{OZT} | Maximum I/O | 5.5 | | ± 0.6 | ± 6.0 | μА | $V_I = V_{IL}, V_{IH}$ |
| | Leakage Current | 3.3 | | | | | $V_O = V_{CC}$, GND |
| I _{CCT} | Maximum I _{CC} /Input | 5.5 | 0.6 | | 1.5 | mA | $V_I = V_{CC} - 2.1V$ |
| I _{OLD} | Minimum Dynamic | 5.5 | | | 75 | mA | V _{OLD} = 1.65V Max |
| I _{OHD} | Output Current (Note 4) | 5.5 | | | -75 | mA | V _{OHD} = 3.85V Min |
| I _{CC} | Maximum Quiescent Supply Current | 5.5 | | 8.0 | 80.0 | μА | V _{IN} = V _{CC} or GND |

140°C

Note 3: All outputs loaded; thresholds on input associated with output under test.

Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

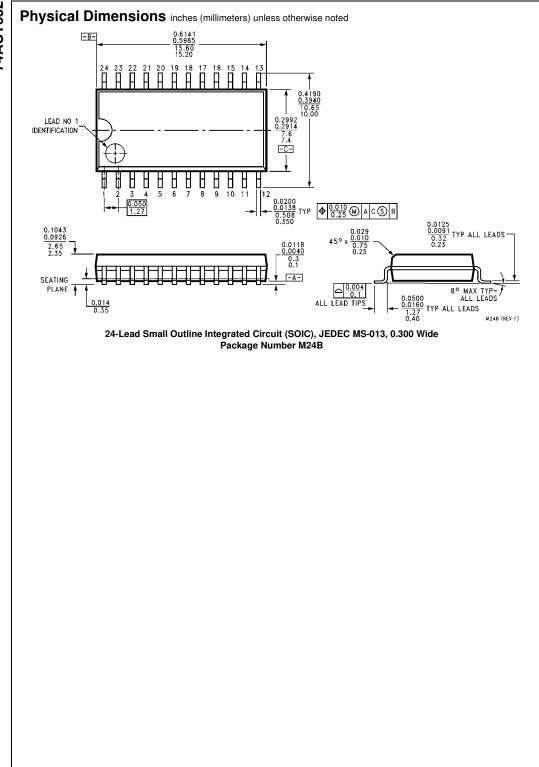
AC Electrical Characteristics

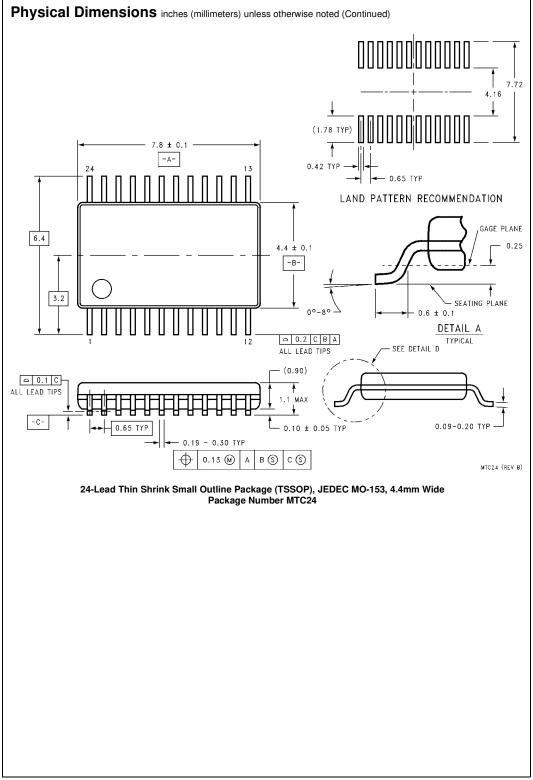
| | Parameter | V _{CC} | $T_A = +25^{\circ}C$ $C_L = 50 \text{ pF}$ | | | $T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$ $C_L = 50 \text{ pF}$ | | Units |
|--------------------|----------------------|-----------------|--|-----|------|---|------|-------|
| Symbol | | (V) | | | | | | |
| | | (Note 5) | Min | Тур | Max | Min | Max | |
| f _{MAX} | Max. Clock Frequency | 5.0 | | | | | | MHz |
| t _{PLH} | Propagation Delay | 5.0 | 2.0 | 7.0 | 9.5 | 2.0 | 10.0 | ns |
| t _{PHL} | Clock to Bus | 5.0 | 2.0 | 7.0 | 9.5 | 2.0 | 10.0 | 115 |
| t _{PLH} | Propagation Delay | 5.0 | 2.0 | 6.5 | 9.0 | 2.0 | 9.5 | ns |
| t _{PHL} | Bus to Bus | 3.0 | 2.0 | 0.5 | 5.0 | 2.0 | 3.5 | 113 |
| t _{PLH} | Propagation Delay | 5.0 | 2.5 | 6.5 | 10.0 | 2.5 | 10.5 | ns |
| t _{PHL} | SBA or SAB to A or B | 3.0 | 2.5 | 0.5 | 10.0 | 2.5 | 10.5 | 113 |
| t _{PZH} | Enable Time | 5.0 | 2.0 | 7.0 | 10.5 | 2.0 | 11.0 | |
| t_{PZL} | OEBA to A (Note 5) | 5.0 | 2.0 | 7.0 | 10.5 | 2.0 | 11.0 | |
| t _{PHZ} | Disable Time | 5.0 | 1.0 | 5.0 | 8.0 | 1.0 | 8.5 | ns |
| t_{PLZ} | OEBA to A (Note 5) | 5.0 | 1.0 | 5.0 | 0.0 | 1.0 | 0.5 | 113 |
| t _{PZH} | Enable Time | 5.0 | 2.0 | 7.0 | 10.5 | 2.0 | 11.0 | |
| t_{PZL} | OEAB to B | 3.0 | 2.0 | 7.0 | 10.5 | 2.0 | 11.0 | |
| t _{PHZ} | Disable Time | 5.0 | 1.0 | 5.0 | 8.0 | 1.0 | 8.5 | ns |
| t_{PLZ} | OEAB to B | 5.0 | 1.0 | 5.0 | 0.0 | 1.0 | 0.5 | 113 |
| t _s (H) | Setup Time, HIGH or | 5.0 | 3.0 | | | 3.0 | | ns |
| $t_s(L)$ | LOW, Bus to Clock | 3.0 | 0.0 | | | 0.0 | | 113 |
| t _h (H) | Hold Time, HIGH or | 5.0 | 1.5 | | | 1.5 | | ns |
| $t_h(L)$ | LOW, Bus to Clock | 5.0 | 1.5 | | | 1.5 | | 113 |
| t _w (H) | Clock Pulse Width | 5.0 | 4.0 | | | 4.0 | | ns |
| $t_w(L)$ | HIGH or LOW | 5.0 | 4.0 | | | 4.0 | | 115 |

Note 5: Voltage Range 5.0 is $5.0V \pm 0.5V$.

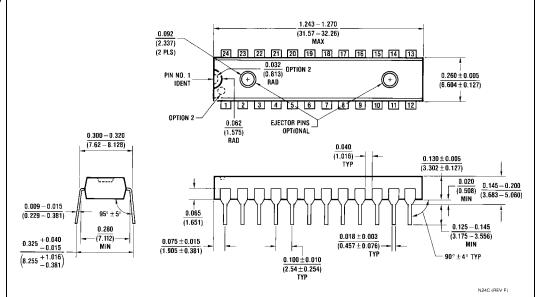
Capacitance

| Symbol | Parameter | Тур | Units | Conditions |
|-----------------|-------------------------------|-----|-------|------------------------|
| C _{IN} | Input Capacitance | 4.5 | pF | V _{CC} = 5.0V |
| C _{PD} | Power Dissipation Capacitance | 54 | pF | $V_{CC} = 5.0V$ |





Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N24C

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